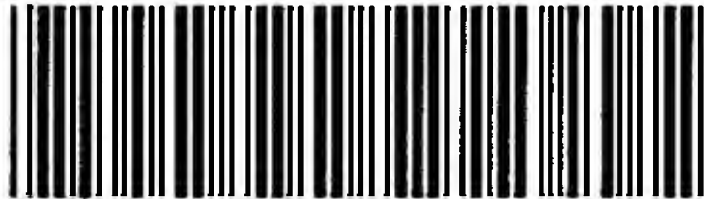


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/707,835	CHEN ET AL.	
	Examiner	Art Unit	
	Gopal C. Ray	2111	

SEARCHED			
Class	Subclass	Date	Examiner
710	305,1,315,313,14,11,63,100,301	9/22/2005	GCR
710	303,74	9/22/2005	GCR
711	115,103	9/22/2005	GCR
711	154	9/22/2005	GCR
713	100	9/22/2005	GCR
370	431,465	9/22/2005	GCR
709	253	9/22/2005	GCR
361	737,748	9/22/2005	GCR
361	684	9/22/2005	GCR
439	55,527	9/22/2005	GCR
710	310,52	9/22/2005	GCR
711	104	9/22/2005	GCR
370	912	9/22/2005	GCR

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PGPUB text search - see interference search printout		9/22/2005	GCR

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
WEST: USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (see search history printouts)	9/21/2005	GCR
EAST: USPT (see search history printouts)	9/21/2005	GCR
NPL: IEEE Xplore (see search history printouts)	9/21/2005	GCR